Notice of References Cited Application/Control No. 10/660,076 Examiner Kim Nguyen Applicant(s)/Patent Under Reexamination RANDALL ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0048649 A1	03-2004	Peterson et al.	463/020
	В	US-2003/0216162 A1	11-2003	Vancura, Olaf	463/10
	С	US-6,309,300 B1	10-2001	Glavich, Paulina	463/26
	D	US-			
	Ε	US-			
	F	US-			•
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0						
	Р						
	Q						
	R						
	s						
	Т						

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.